# $\frac{\text{MOSFET}}{\text{POWERTRENCH}^{\$}} - \text{N-Channel,} \\ \text{30 V, 174 A, 1.3 m} \\ \Omega$

#### **General Description**

This N-Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance. This device is well suited for applications where ultra low  $r_{DS(on)}$  is required in small spaces such as High performance VRM, POL and Oring functions.

#### **Features**

- Extended T<sub>J</sub> Rating to 175°C
- Max  $r_{DS(on)} = 1.3 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 30 \text{ A}$
- Max  $r_{DS(on)} = 1.8 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 25 \text{ A}$
- High Performance Technology for Extremely Low r<sub>DS(on)</sub>
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- DC DC Buck Converters
- Point of Load
- High Efficiency Load Switch and Low Side Switching
- Oring FET

#### MOSFET MAXIMUM RATINGS (T<sub>A</sub> = 25°C Unless Otherwise Noted)

Symbol	Parameter	Ratings	Units	
VDS	Drain to Source Voltage	30	V	
Vgs	Gate to Source Volage (Note 4)	±20	V	
I <sub>D</sub>	$ \begin{array}{lll} \text{Drain Current} & & & \\ -\text{Continuous} & & & \\ -\text{Pulsed} & & & \\ \end{array} $	174 123 30 835	Α	
Eas	Single Pulse Avalance Energy (Note 3)	153	mJ	
P <sub>D</sub>	Power Dissipation $T_C = 25^{\circ}C$	65	W	
	Power Dissipation T <sub>A</sub> = 25°C (Note 1a)	2.8		
Тл, Тѕтс	Operating and Storage Junction Temperature Range	-55 to +150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

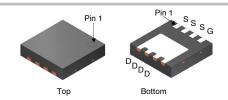
#### THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
Rejc	Thermal Resistance, Junction to Case	1.3	°C/W
RөJA	Thermal Resistance, Junction to Ambient (Note 1a)	53	°C/W



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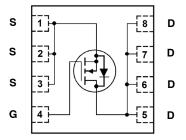


PQFN8 3.3x3.3, 0.65P CASE 483AW Power 33

#### **MARKING DIAGRAM**



\$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
FDMC8010FT	= Specific Device Code



#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 2 of this data sheet.

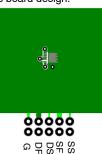
#### PACKAGE MARKING AND ORDERING INFORMATION

	Device Marking	Device	Package	Reel Size	Tape Width	Quantity
Γ	FDMC8010ET	FDMC8010ET30	Power 33	13"	12 mm	3000 Units

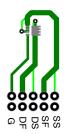
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARAC	TERISTICS					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, referenced to 25°C		15		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
ON CHARACT	TERISTICS					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	1.2	1.5	2.5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 1 mA, referenced to 25°C		-5		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	ce V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A		0.9	1.3	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 25 A		1.3	1.8	_
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A, T <sub>J</sub> = 125°C		1.3	2	
9FS	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 30 A		188		S
DYNAMIC CH	ARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,		4405	5860	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz		1570	2090	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1		167	250	pF
R <sub>g</sub>	Gate Resistance		0.1	0.5	1.25	Ω
SWITCHING C	CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 30 \text{ A}, V_{GS} = 10 \text{ V},$		15	27	ns
t <sub>r</sub>	Rise Time	$R_{GEN} = 6 \Omega$		7.5	15	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			40	64	ns
t <sub>f</sub>	Fall Time			5.3	11	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V V <sub>DD</sub> = 15 V		67	94	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $I_D = 30 \text{ A}$		32	45	nC
Qgs	Gate to Source Charge			10		nC
Qgd	Gate to Drain "Miller" Charge			9.5		nC
DRAIN-SOUR	RCE DIODE CHARACTERISTICS	•				
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2 \text{ A} \text{ (Note 2)}$		0.6	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 30 A (Note 2)		0.7	1.2	1
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30 A, di/dt = 100 A/μs		49	78	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1		29	46	nC

#### NOTES:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.</li>
   E<sub>AS</sub> of 153 mJ is based on starting T<sub>J</sub> = 25°C, L = 0.3 mH, I<sub>AS</sub> = 32 A, V<sub>DD</sub> = 27 V, V<sub>GS</sub> = 10 V. 100% test at L = 0.1 mH, I<sub>AS</sub> = 47 A.
   As an N-ch device, the negative Vgs rating is for low dety cycle pulse occurrence only. No continuous rating is implied.
   Pulsed I device refer to Figure 11 SOA graph for more details.

- 6. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

#### **TYPICAL CHARACTERISTICS**

T<sub>J</sub> = 25°C Unless Otherwise Noted

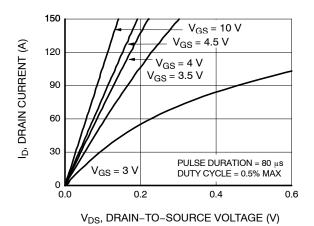


Figure 1. On-Region Characteristics

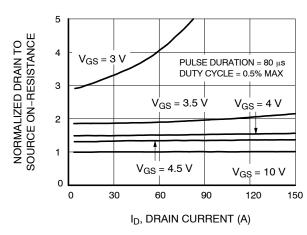


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

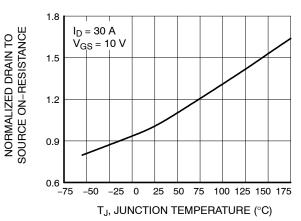
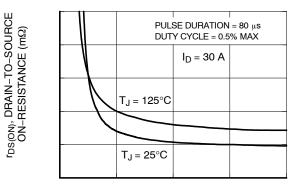


Figure 3. Normalized On Resistance vs Junction Temperature



V<sub>GS</sub>, GATE TO SOURCE VOLTAGE (V)

Figure 4. On-Resistance vs Gate to Source Voltage

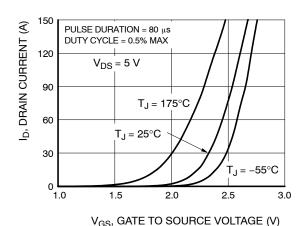
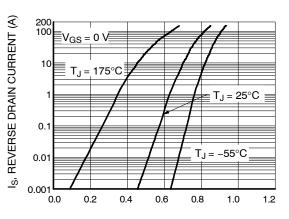


Figure 5. Transfer Characteristics



V<sub>SD</sub>, BODY DIODE FORWARD VOLTAGE (V)

Figure 6. Source to Drain Diode Forward
Voltage vs Source Current

#### TYPICAL CHARACTERISTICS (continued)

T<sub>J</sub> = 25°C Unless Otherwise Noted

CAPACITANCE (pF)

ID, DRAIN CURRENT (A)

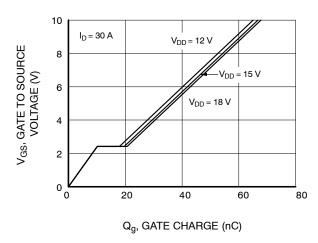


Figure 7. Gate Charge Characteristics

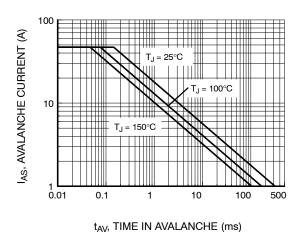


Figure 9. Unclamped Inductive Switching Capability

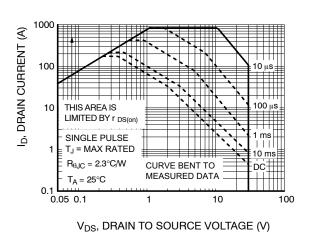
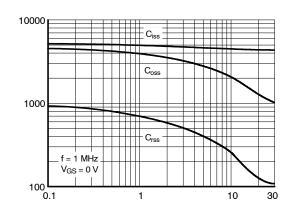
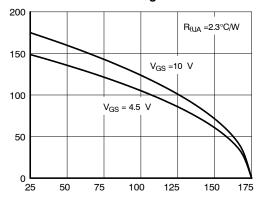


Figure 11. Forward Bias Safe Operating Area



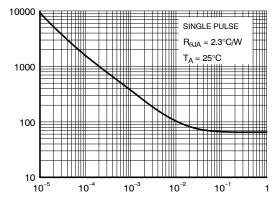
V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

Figure 8. Capacitance vs Drain to Source Voltage



T<sub>C</sub>, CASE TEMPERATURE (°C)

Figure 10. Maximum Continuous Drain Current vs Case Temperature



t, PULSE WIDTH (sec)

Figure 12. Single Pulse Maximum Power Dissipation

P(PK), PEAK TRANSIENT POWER (W)

#### TYPICAL CHARACTERISTICS (continued)

T<sub>J</sub> = 25°C Unless Otherwise Noted

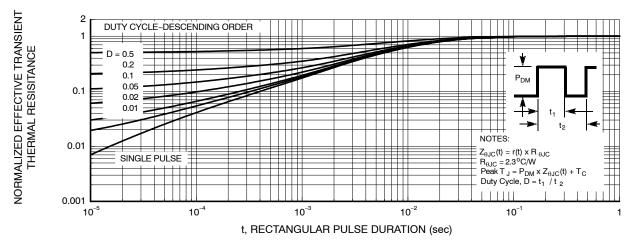


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

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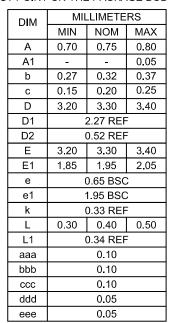


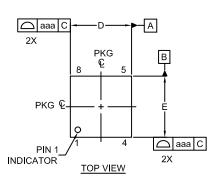
# **WDFN8 3.3X3.3, 0.65P**CASE 483AW ISSUE A

**DATE 10 SEP 2019** 

#### NOTES:

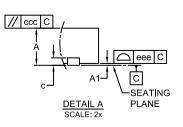
- 1. CONTROLLING DIMENSION: MILLIMETERS.
- 2. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

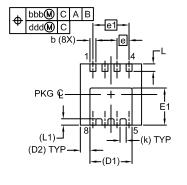






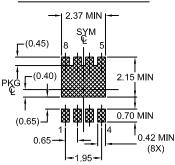
FRONT VIEW





**BOTTOM VIEW** 

## LAND PATTERN RECOMMENDATION\*



\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

### GENERIC MARKING DIAGRAM\*

XXXX AYWW XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1		

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